

Supporting Information

Spectroscopic and Magnetic Investigations of Spin-frustrated Mn-doped CoAl_2O_4 Spinel

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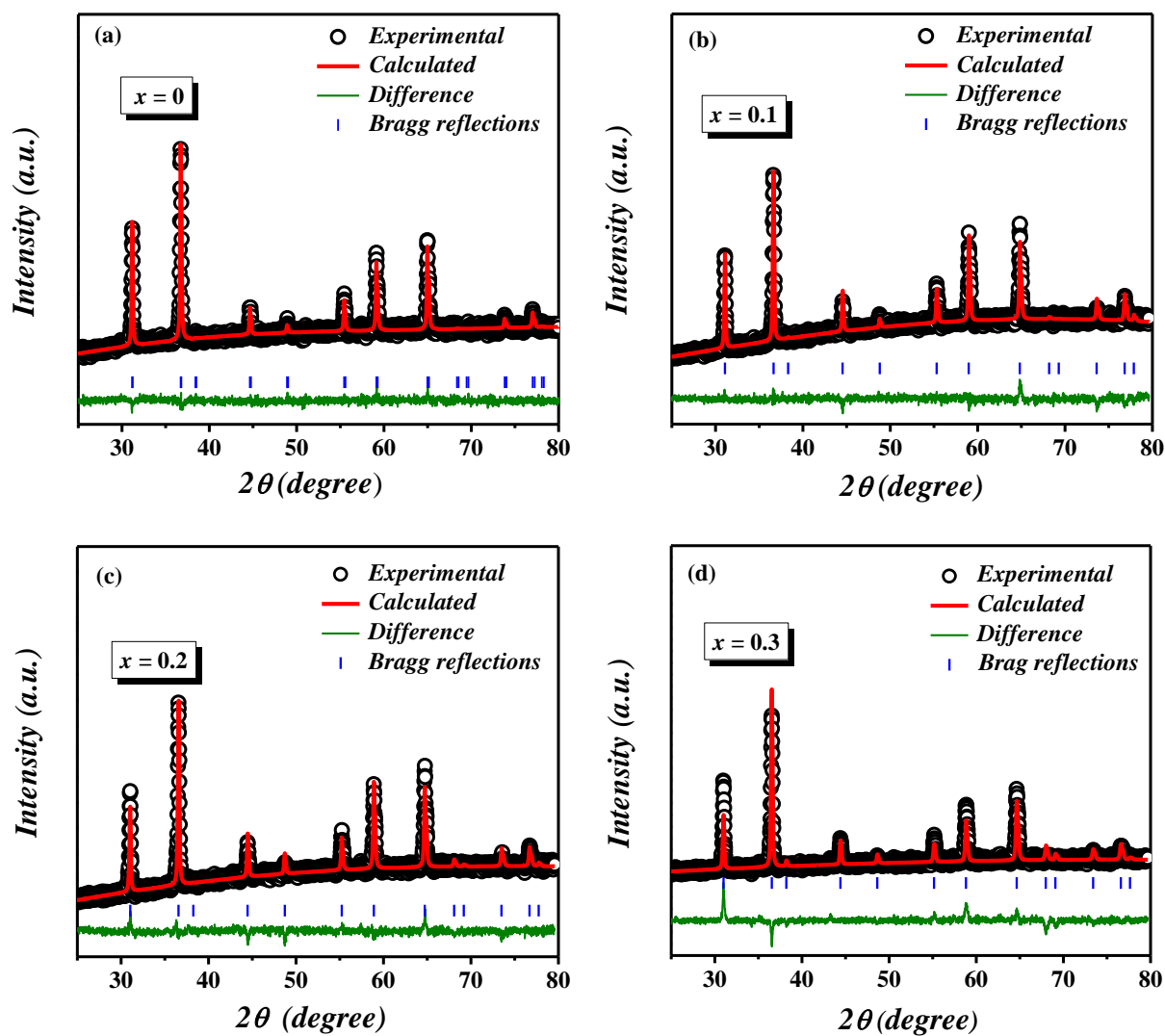


Fig.S1 Room temperature Rietveld fitted x-ray diffraction patterns for $x =$ (a) 0, (b) 0.1, (c) 0.2, and (d) 0.3 samples of $\text{Co}_{1-x}\text{Mn}_x\text{Al}_2\text{O}_4$. Structural parameters obtained from the Rietveld refinements are shown in Table S1 in the supplemental material.

Table S1 Structural parameters obtained from Rietveld refinements of the room temperature x-ray diffraction pattern of $\text{Co}_{1-x}\text{Mn}_x\text{Al}_2\text{O}_4$ (Space group: $Fd\bar{3}m$) ($\alpha = \beta = \gamma = 90^\circ$). The errors are given in the parentheses.

(a) $x = 0$; $a = b = c = 8.1162(4)$ Å; $R_{wp} = 3.8$; $R_p = 2.7$; $\chi^2 = 1.18$; $\alpha = 0.0804(2)$

Atom	x	y	z	Occupancy
Co (8a)	1/8	1/8	1/8	0.9196(3)
Al (8a)	1/8	1/8	1/8	0.0804(2)
Al (16d)	1/2	1/2	1/2	0.9598(9)
Co (16d)	1/2	1/2	1/2	0.0402(1)
O (32e)	0.2620(1)	0.2620(1)	0.2620(1)	1.000

(b) $x = 0.1$; $a = b = c = 8.1272(3)$ Å; $R_{wp} = 2.71$; $R_p = 2.09$; $\chi^2 = 1.15$; $\alpha = 0.0780(4)$

Atom	x	y	z	Occupancy
Co (8a)	1/8	1/8	1/8	0.8318(7)
Al (8a)	1/8	1/8	1/8	0.0780(4)
Mn (8a)	1/8	1/8	1/8	0.0902(1)
Al (16d)	1/2	1/2	1/2	0.9561(1)
Co (16d)	1/2	1/2	1/2	0.0390(2)
Mn (16d)	1/2	1/2	1/2	0.0049(7)
O (32e)	0.2626(3)	0.2626(3)	0.2626(3)	1.000

(c) $x = 0.2$; $a = b = c = 8.1392(3)$ Å; $R_{wp} = 3.12$; $R_p = 2.30$; $\chi^2 = 1.27$; $\alpha = 0.0762(2)$

Atom	x	y	z	Occupancy
Co (8a)	1/8	1/8	1/8	0.7434(5)
Al (8a)	1/8	1/8	1/8	0.0762(2)
Mn (8a)	1/8	1/8	1/8	0.1804(2)
Al (16d)	1/2	1/2	1/2	0.9521(1)
Co (16d)	1/2	1/2	1/2	0.0381(3)
Mn (16d)	1/2	1/2	1/2	0.0098(9)
O(32e)	0.2629(5)	0.2629(5)	0.2629(5)	1.000

(d) $x = 0.3$; $a = b = c = 8.1481(6)$ Å; $R_{wp} = 4.30$; $R_p = 2.91$; $\chi^2 = 1.60$; $\alpha = 0.0742(3)$

Atom	x	y	z	Occupancy
Co (8a)	1/8	1/8	1/8	0.6758(6)
Al (8a)	1/8	1/8	1/8	0.0742(3)
Mn(8a)	1/8	1/8	1/8	0.2500(1)
Al(16d)	1/2	1/2	1/2	0.9379(6)
Co(16d)	1/2	1/2	1/2	0.0371(2)
Mn (16d)	1/2	1/2	1/2	0.0250(2)
O(32e)	0.2630(2)	0.2630(2)	0.2630(2)	1.000

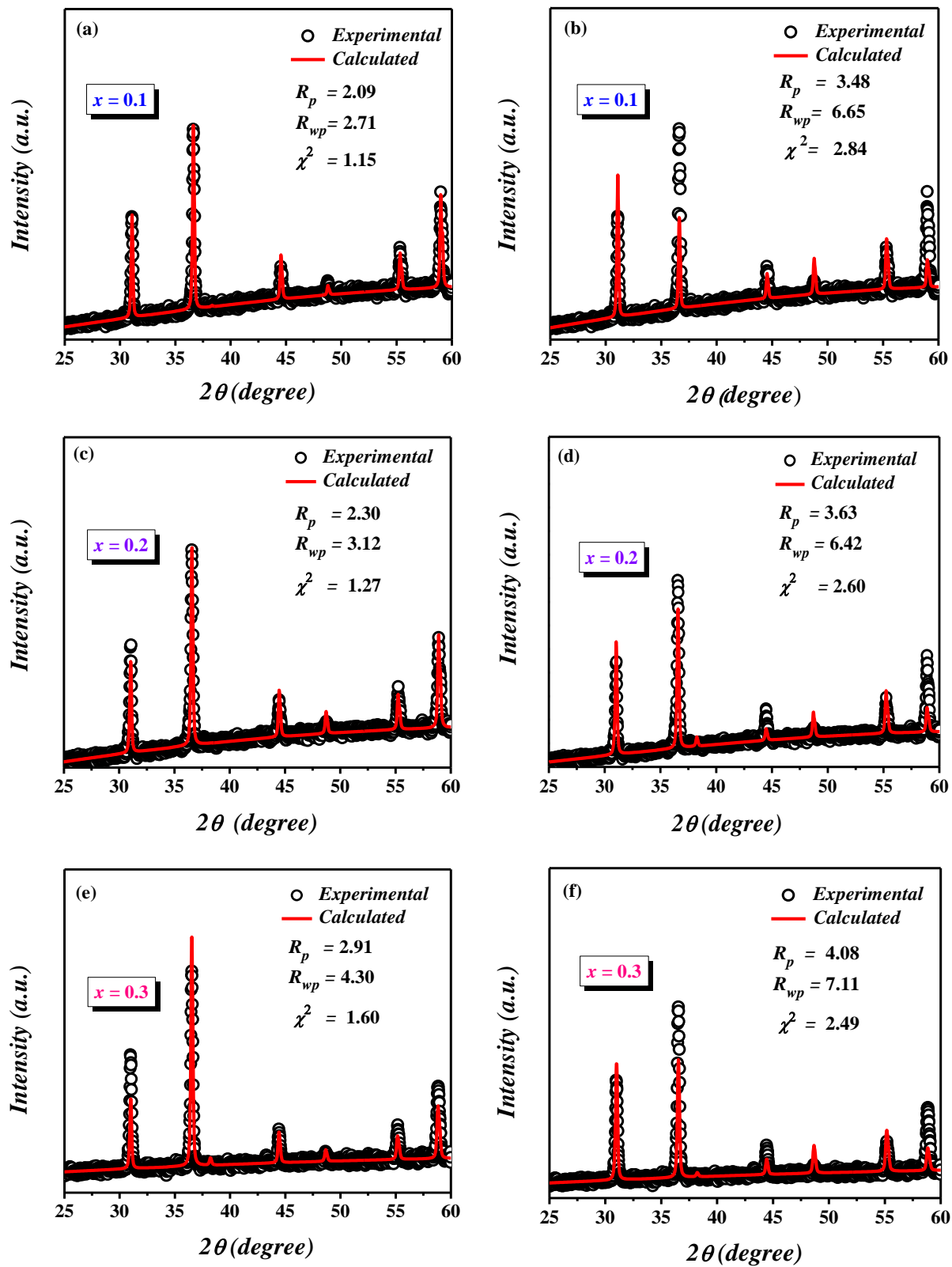


Fig. S2 Room-temperature Rietveld fitted XRD patterns considering different distributions of the Mn^{2+} and Co^{2+} over the two types of sites for (a-b) $x = 0.1$, (c-d) $x = 0.2$, and (e-f) $x = 0.3$.

Table S2 The values of χ^2 of Mn-doped CoAl_2O_4 samples for different distributions of Mn^{2+} and Co^{2+} over the two types of sites.

	χ^2	Atom	Co (8a)	Al (8a)	Mn (8a)	Al (16d)	Co(16d)	Mn (16d)
$x = 0.1$	(a) 1.15	Occupancy	0.8318(7)	0.0780(4)	0.0902(1)	0.9561(1)	0.0390(2)	0.0049(7)
	(b) 2.84		0.8538(7)	0.0760(2)	0.0702(4)	0.9471(2)	0.0380(1)	0.0149(8)
$x = 0.2$	(c) 1.27	Occupancy	0.7434(5)	0.0762(2)	0.1804(2)	0.9521(1)	0.0381(3)	0.0098(9)
	(d) 2.60		0.7776(8)	0.0720(3)	0.1504(2)	0.9392(3)	0.0360(2)	0.0248(9)
$x = 0.3$	(e) 1.60	Occupancy	0.6758(6)	0.0742(3)	0.2500(1)	0.9379(6)	0.0371(2)	0.0250(2)
	(f) 2.49		0.6594(5)	0.0704(3)	0.2702(4)	0.950(1)	0.0352(1)	0.0148(9)

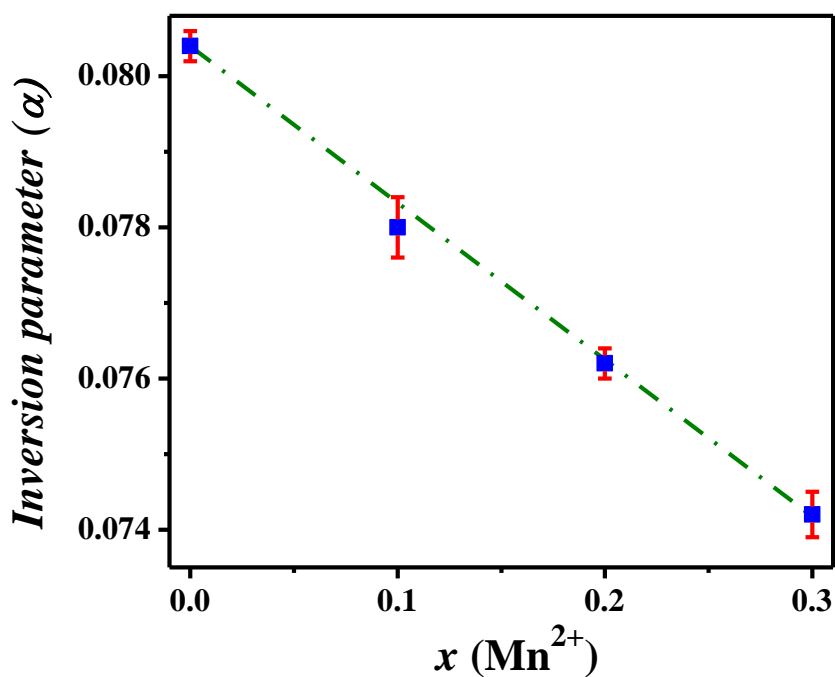


Fig. S3 Variation of *Inversion parameter* (α) with the compositions, as obtained from the Rietveld analysis of the best-fitted XRD patterns.

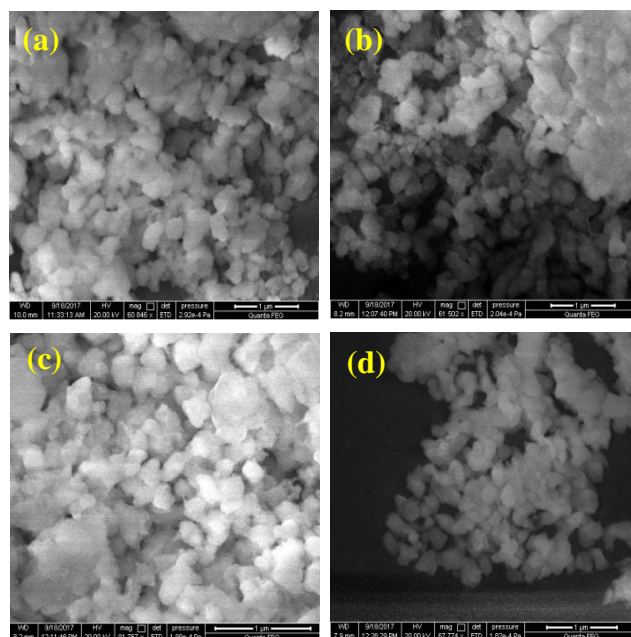


Fig. S4 SEM micrographs of $\text{Co}_{1-x}\text{Mn}_x\text{Al}_2\text{O}_4$ (a) $x = 0$, (b) $x = 0.1$, (c) $x = 0.2$ and (d) $x = 0.3$.

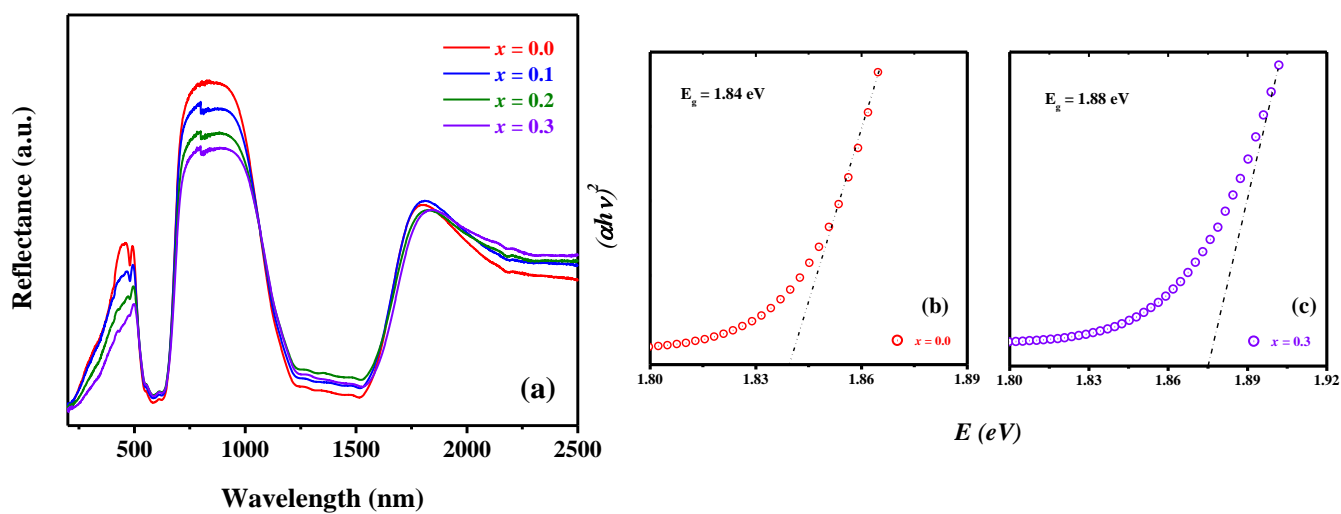


Fig. S5 (a) Room temperature Reflectance spectra for $\text{Co}_{1-x}\text{Mn}_x\text{Al}_2\text{O}_4$. Tauc plots $[(\alpha h\nu)^2 \text{ vs. photon energy } (E)]$ for (b) $x = 0$ and (c) $x = 0.3$.

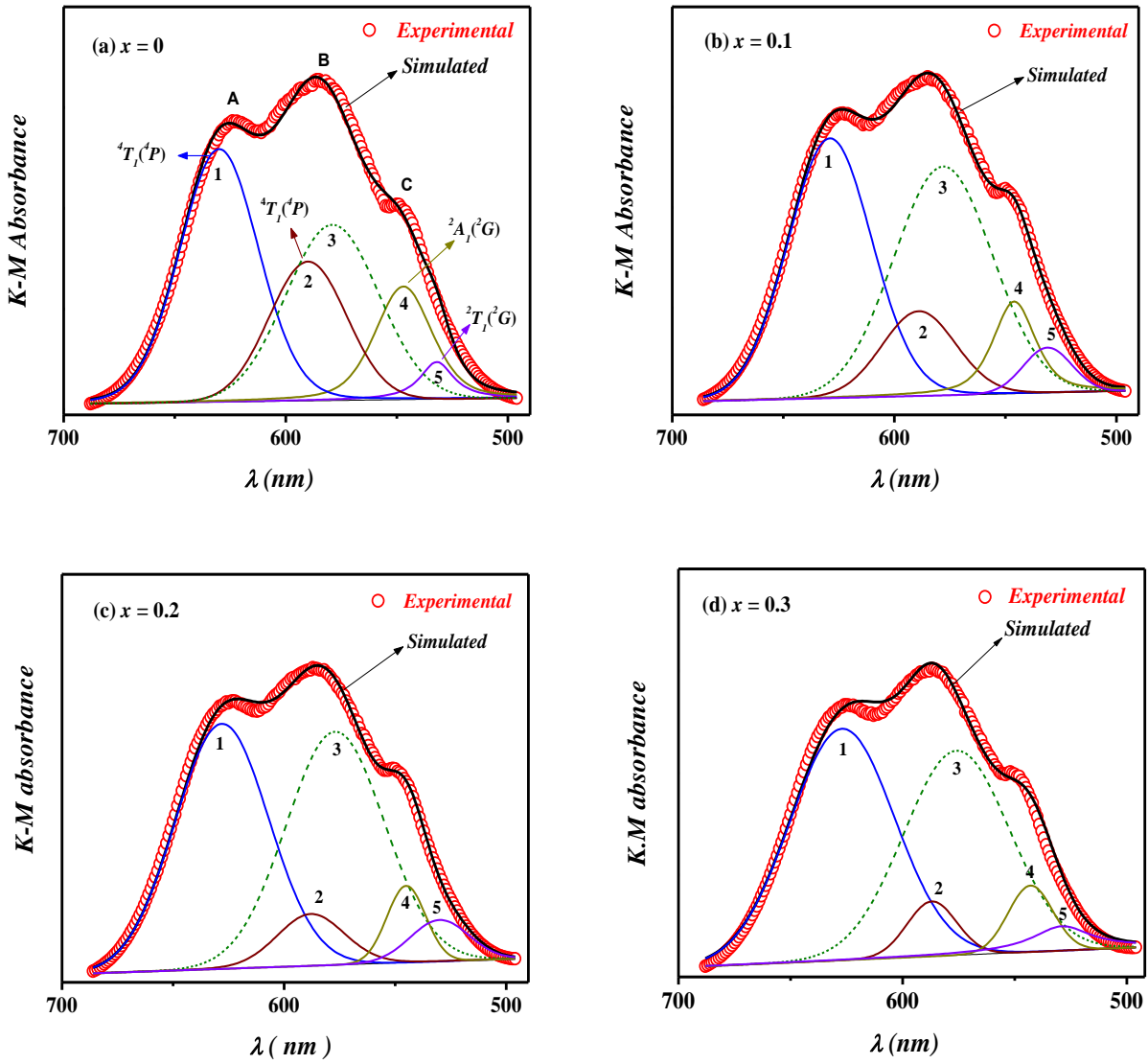


Fig. S6 De-convoluted UV spectrum of $\text{Co}_{1-x}\text{Mn}_x\text{Al}_2\text{O}_4$ where (a) $x = 0$, (b) $x = 0.1$, (c) $x = 0.2$ and (d) $x = 0.3$.

Table S3 De-convoluted peak position obtained from room temperature UV spectrum of $\text{Co}_{1-x}\text{Mn}_x\text{Al}_2\text{O}_4$.

Sample	Peak Position (nm)	Intensity (%)	Peak Position (nm)	Intensity (%)	Peak Position (nm)	Intensity (%)	Peak Position (nm)	Intensity (%)	Peak Position (nm)	Intensity (%)
	1		2		3		4		5	
$x = 0$	630	36	590	18	579	28	547	13	532	3.12
$x = 0.1$	629	38	589	11	578	38	546	8	531	3.66
$x = 0.2$	628	42	588	6	577	42	543	5.31	530	4.25
$x = 0.3$	627	45	586	5	576	40	543	5.46	528	4.09